

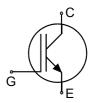
## **IGBT3** Power Chip

### Features:

- 1700V Trench & Field Stop technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

## This chip is used for:

- power modules
- **Applications:**
- drives



Chip Type	V <sub>CE</sub>	I <sub>C</sub>	Die Size	Package
SIGC186T170R3E	1700V	150A	13.63 x 13.63 mm <sup>2</sup>	sawn on foil

### **Mechanical Parameters**

Raster size	13.63 x 13.63		
Emitter pad size (incl. gate pad)	8 x ( 5.62 x 2.71 )	-	
Gate pad size	1.12 x 1.12	mm <sup>2</sup>	
Area total	185.8		
Thickness	190	μm	
Wafer size	200	mm	
Max.possible chips per wafer	137		
Passivation frontside	Photoimide		
Pad metal	3200 nm AlSiCu		
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding		
Die bond	Electrically conductive glue or solder		
Wire bond	Al, <500µm		
Reject ink dot size	Ø 0.65mm ; max 1.2mm		
Recommended storage environment	Store in original container, in dry nitrogen, in dark environment, < 6 month at an ambient temperature of 23°C		



## **Maximum Ratings**

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage, <i>T</i> <sub>vj</sub> =25 °C	V <sub>CE</sub>	1700	V	
DC collector current, limited by $T_{vj max}$	I <sub>C</sub>	1)	Α	
Pulsed collector current, $t_p$ limited by $T_{vj max}$	I <sub>c,puls</sub>	450	Α	
Gate emitter voltage	V <sub>GE</sub>	±20	V	
Junction temperature range	T <sub>vj</sub>	-40 +175	°C	
Operating junction temperature	T <sub>vj</sub>	-40+150	°C	
Short circuit data <sup>2)</sup> $V_{GE}$ = 15V, $V_{CC}$ = 1000V, $T_{vj}$ = 150°C	t <sub>sc</sub>	10	μs	
Reverse bias safe operating area <sup>2</sup> ) (RBSOA)	$I_{C,max} = 300A, V_{CE,max} = 1700V$ $T_{vj} \le 150^{\circ}C$			

<sup>1</sup>) depending on thermal properties of assembly

<sup>2</sup>) not subject to production test - verified by design/characterization

## Static Characteristic (tested on wafer), $T_{vj}$ =25 °C

Parameter	Symbol	Conditions	Value			Unit	
	Gymbol	Conditions	min. ty		max.		
Collector-Emitter breakdown voltage	V <sub>(BR)CES</sub>	V <sub>GE</sub> =0V , <i>I</i> <sub>C</sub> = 4 mA	1700				
Collector-Emitter saturation voltage	V <sub>CEsat</sub> <sup>3)</sup>	V <sub>GE</sub> =15V, <i>I</i> <sub>C</sub> =150A	1.6	2	2.4	V	
Gate-Emitter threshold voltage	V <sub>GE(th)</sub>	<i>I</i> <sub>C</sub> =6mA , <i>V</i> <sub>GE</sub> = <i>V</i> <sub>CE</sub>	5.2	5.8	6.4		
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1700V , V <sub>GE</sub> =0V			8.2	μA	
Gate-Emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V			600	nA	
Integrated gate resistor	r <sub>G</sub>			5		Ω	

<sup>3)</sup>Vcesat tested at lower current

## **Dynamic Characteristic** (not subject to production test - verified by design / characterization), $T_{vj}$ =25 °C

Parameter	Symbol	Conditions	Value			Unit
Falameter	Symbol		min.	typ.	max.	Unit
Input capacitance	Cies	V <sub>CE</sub> =25V, V <sub>GE</sub> =0V, <i>f</i> =1MHz		13196		
Reverse transfer capacitance	Cres			438		- pF

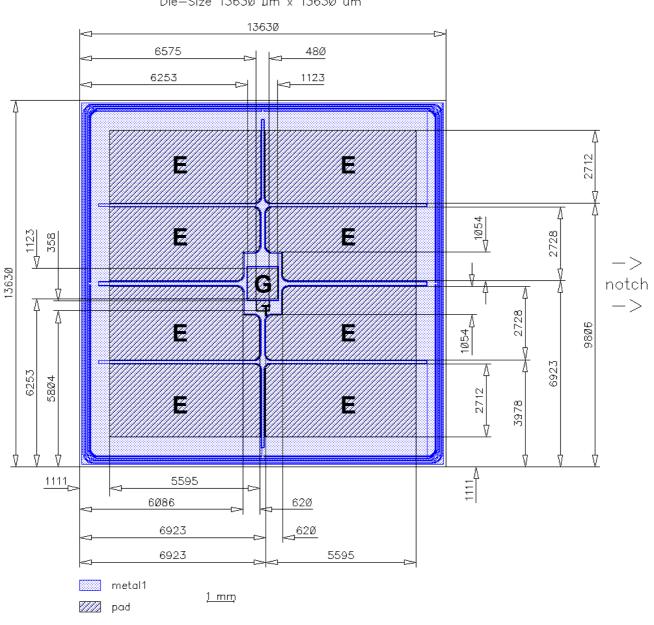


## **Further Electrical Characteristic**

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.



## **Chip Drawing**



Die-Size 13630 um x 13630 um

E = Emitter

- G = Gate
- T = Test pad do not contact



#### Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

#### **Revision History**

Version	Subjects (major changes since last revision)	Date
2.1	Change wafer size to 200 mm	14.04.2010

Published by Infineon Technologies AG 81726 Munich, Germany © 2010 Infineon Technologies AG All Rights Reserved.

### Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

#### Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

### Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office. Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon Technologies(英飞凌)